

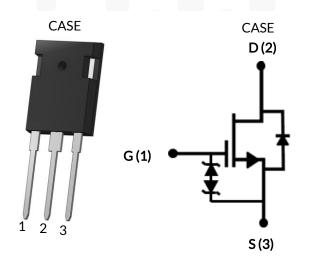


# $750V-44m\Omega$ SiC FET

Rev. B, July 2021

#### DATASHEET

# UJ4C075044K3S



Part NumberPackageMarkingUJ4C075044K3STO-247-3LUJ4C075044K3S



#### Description

The UJ4C075044K3S is a 750V,  $44m\Omega$  G4 SiC FET. It is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-3L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

#### Features

- On-resistance R<sub>DS(on)</sub>: 44mΩ (typ)
- Operating temperature: 175°C (max)
- Excellent reverse recovery: Q<sub>rr</sub> = 67nC
- Low body diode V<sub>FSD</sub>: 1.2V
- Low gate charge: Q<sub>G</sub> = 37.8nC
- Threshold voltage V<sub>G(th)</sub>: 4.8V (typ) allowing 0 to 15V drive
- Low intrinsic capacitance
- ESD protected: HBM class 2 and CDM class C3

### Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating





## Maximum Ratings

Parameter	Symbol	<b>Test Conditions</b>	Value	Units
Drain-source voltage	V <sub>DS</sub>		750	V
Coto course veltare	V	DC	-20 to +20	V
Gate-source voltage	V <sub>GS</sub>	AC (f > 1Hz)	-25 to +25	V
Continuous drain current <sup>1</sup>	1	T <sub>C</sub> =25°C	37.4	А
Continuous drain current	I <sub>D</sub>	T <sub>C</sub> =100°C	27.6	А
Pulsed drain current <sup>2</sup>	I <sub>DM</sub>	T <sub>C</sub> = 25°C	110	А
Single pulsed avalanche energy <sup>3</sup>	E <sub>AS</sub>	L=15mH, I <sub>AS</sub> =2.1A	33	mJ
SiC FET dv/dt ruggedness	dv/dt	$V_{DS} \le 500V$	200	V/ns
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25°C	203	W
Maximum junction temperature	T <sub>J,max</sub>		175	°C
Operating and storage temperature	T <sub>J</sub> , T <sub>STG</sub>		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	TL		250	°C

1. Limited by  $T_{J,max}$ 

2. Pulse width  $t_p$  limited by  $T_{J,max}$ 

3. Starting  $T_J = 25^{\circ}C$ 

Thermal Characteristics

Parameter	Symbol	Test Conditions		Units		
	Symbol	Test Conditions	Min	Тур	Max	Units
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.57	0.74	°C/W





## Electrical Characteristics (T<sub>J</sub> = +25°C unless otherwise specified)

## **Typical Performance - Static**

Parameter	Cump al	Test Conditions		Value			
Parameter	Symbol	lest Conditions	Min	Тур	Max	– Units	
Drain-source breakdown voltage	BV <sub>DS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =1mA	750			V	
		V <sub>DS</sub> =750V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C		1.5	15		
Total drain leakage current	I <sub>DSS</sub>	V <sub>DS</sub> =750V, V <sub>GS</sub> =0V, T <sub>J</sub> =175°C	15 DV, T <sub>J</sub> =175°C DV, T <sub>I</sub> =25°C,		μA		
Total gate leakage current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, T <sub>J</sub> =25°C, V <sub>GS</sub> =-20V / +20V		6	±20	μA	
Drain-source on-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =12V, I <sub>D</sub> =25A, T <sub>J</sub> =25°C		44	56		
		V <sub>GS</sub> =12V, I <sub>D</sub> =25A, T <sub>J</sub> =125°C		75		mΩ	
		V <sub>GS</sub> =12V, I <sub>D</sub> =25A, T <sub>J</sub> =175°C		101			
Gate threshold voltage	V <sub>G(th)</sub>	$V_{DS}$ =5V, $I_{D}$ =10mA	4	4.8	6	V	
Gate resistance	R <sub>G</sub>	f=1MHz, open drain		4.5		Ω	

#### Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions	onditions		Value		
	Symbol	Test Conditions	Min	Тур	Max	Units	
Diode continuous forward current <sup>1</sup>	ا <sub>s</sub>	T <sub>C</sub> = 25°C			37.4	А	
Diode pulse current <sup>2</sup>	I <sub>S,pulse</sub>	T <sub>C</sub> =25°C			110	А	
Forward voltage	V <sub>FSD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =10A, T <sub>J</sub> =25°C		1.2	1.36	V	
	• FSD	V <sub>GS</sub> =0V, I <sub>S</sub> =10A, T <sub>J</sub> =175°C		1.42		v	
Reverse recovery charge	Q <sub>rr</sub>	$V_R$ =400V, I <sub>S</sub> =25A, $V_{GS}$ =0V, R <sub>G_EXT</sub> =5 $\Omega$		67		nC	
Reverse recovery time	t <sub>rr</sub>	di/dt=1200A/μs, T <sub>J</sub> =25°C		12		ns	
Reverse recovery charge	Q <sub>rr</sub>	V <sub>R</sub> =400V, I <sub>S</sub> =25A, V <sub>GS</sub> =0V, R <sub>G_EXT</sub> =5Ω		93		nC	
Reverse recovery time	t <sub>rr</sub>	di/dt=1200A/μs, Τ <sub>J</sub> =150°C		12		ns	





#### **Typical Performance - Dynamic**

Deveneter	Cumple of	Test Conditions		Value		Linite
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
Input capacitance	C <sub>iss</sub>			1400		
Output capacitance	C <sub>oss</sub>	- V <sub>DS</sub> =400V, V <sub>GS</sub> =0V - f=100kHz -		55		pF
Reverse transfer capacitance	C <sub>rss</sub>			2.5		
Effective output capacitance, energy related	C <sub>oss(er)</sub>	V <sub>DS</sub> =0V to 400V, V <sub>GS</sub> =0V		66.4		pF
Effective output capacitance, time related	C <sub>oss(tr)</sub>	$V_{DS}$ =0V to 400V, $V_{GS}$ =0V		131		pF
C <sub>OSS</sub> stored energy	E <sub>oss</sub>	$V_{DS}$ =400V, $V_{GS}$ =0V		5.3		μJ
Total gate charge	Q <sub>G</sub>	– V <sub>DS</sub> =400V, I <sub>D</sub> =25A, –		37.8		
Gate-drain charge	$Q_{GD}$	$V_{DS} = 400 V, I_D = 25 A,$ $V_{GS} = 0V \text{ to } 15 V$		8		nC
Gate-source charge	Q <sub>GS</sub>	VGS - 0V 10 13 V		11.8		
Turn-on delay time	t <sub>d(on)</sub>	Notes 4 and 5,		14		
Rise time	t <sub>r</sub>	$V_{DS}$ =400V, $I_{D}$ =25A, Gate		35		
Turn-off delay time	t <sub>d(off)</sub>	Driver =0V to +15V, Turn-on $R_{G,EXT} = 1\Omega$ ,		42		ns
Fall time	t <sub>f</sub>	Turn-off $R_{G,EXT} = 5\Omega$ ,		10		
Turn-on energy including R <sub>s</sub> energy	E <sub>ON</sub>	inductive Load,		259		
Turn-off energy including $R_s$ energy	E <sub>OFF</sub>	FWD: same device with $V_{GS}$ = 0V and $R_G = 5\Omega$ , RC		60		-
Total switching energy	E <sub>TOTAL</sub>	snubber: $R_s = 15\Omega$ and		319		μJ
Snubber $R_s$ energy during turn-on	E <sub>RS_ON</sub>	C <sub>s</sub> =68pF,		2		
Snubber R <sub>s</sub> energy during turn-off	$E_{RS_OFF}$	T_=25°C		3		
Turn-on delay time	t <sub>d(on)</sub>	Notes 4 and 5,		16		
Rise time	t <sub>r</sub>	V <sub>DS</sub> =400V, I <sub>D</sub> =25A, Gate		35		
Turn-off delay time	t <sub>d(off)</sub>	Driver =0V to +15V,		45		ns
Fall time	t <sub>f</sub>	Turn-on $R_{G,EXT} = 1\Omega$ , Turn-off $R_{G,EXT} = 5\Omega$ ,		10		-
Turn-on energy including R <sub>s</sub> energy	E <sub>ON</sub>	inductive Load,		289		
Turn-off energy including R <sub>s</sub> energy	E <sub>OFF</sub>	FWD: same device with $V_{GS}$ = 0V and $R_G = 5\Omega$ , RC		70		
Total switching energy	E <sub>TOTAL</sub>	snubber: $R_s = 15\Omega$ and		359		μJ
Snubber $R_s$ energy during turn-on	E <sub>RS_ON</sub>	C <sub>s</sub> =68pF,		2		]
Snubber R <sub>s</sub> energy during turn-off	$E_{RS_OFF}$	TJ=150°C		3		

4. Measured with the switching test circuit in Figure 35.

5. In this datasheet, all the switching energies (turn-on energy, turn-off energy and total energy) presented in the tables and Figures include the device RC snubber energy losses.





### Typical Performance - Dynamic (continued)

Parameter	Symphol	Test Conditions		– Units			
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units	
Turn-on delay time	t <sub>d(on)</sub>			13			
Rise time	t <sub>r</sub>	Note 6, V <sub>DS</sub> =400V, I <sub>D</sub> =25A, Gate		34			
Turn-off delay time	t <sub>d(off)</sub>	Driver = $0V$ to +15V,		42		ns	
Falltime	t <sub>f</sub>	Turn-on $R_{G,EXT} = 1\Omega$ ,		10		-	
Turn-on energy including R <sub>s</sub> energy	E <sub>ON</sub>	Turn-off R <sub>G,EXT</sub> =5Ω, inductive Load,		221			
Turn-off energy including R <sub>s</sub> energy	E <sub>OFF</sub>	$= \begin{array}{c c} & \text{inductive Load,} \\ \hline FWD: UJ3D06512TS, RC \\ \hline & \text{snubber: } R_S=15\Omega \text{ and} \\ \hline & C_S=68pF, \end{array}$		66		μ	
Total switching energy	E <sub>TOTAL</sub>			287			
Snubber R <sub>s</sub> energy during turn-on	E <sub>RS_ON</sub>	C <sub>s</sub> =oopF, Τ <sub>l</sub> =25°C		3			
Snubber R <sub>s</sub> energy during turn-off	E <sub>RS_OFF</sub>			6			
Turn-on delay time	t <sub>d(on)</sub>			13			
Rise time	t <sub>r</sub>	Note 6,		33			
Turn-off delay time	t <sub>d(off)</sub>	<ul> <li>V<sub>DS</sub>=400V, I<sub>D</sub>=25A, Gate</li> <li>Driver =0V to +15V,</li> </ul>		45		ns	
Falltime	t <sub>f</sub>	Turn-on $R_{G,EXT}$ = 1 $\Omega$ ,		10			
Turn-on energy including R <sub>s</sub> energy	E <sub>ON</sub>	Turn-off $R_{G,EXT}=5\Omega$ , inductive Load,		233			
Turn-off energy including R <sub>s</sub> energy	E <sub>OFF</sub>	FWD: UJ3D06512TS, RC		88			
Total switching energy	E <sub>TOTAL</sub>	snubber: $R_s = 15\Omega$ and		321		μJ	
Snubber R <sub>s</sub> energy during turn-on	E <sub>RS_ON</sub>	– C <sub>S</sub> =68pF, – T <sub>I</sub> =150°C		3			
Snubber R <sub>s</sub> energy during turn-off	E <sub>RS_OFF</sub>			6			

6. Measured with the switching test circuit in Figure 36.





#### **Typical Performance Diagrams**

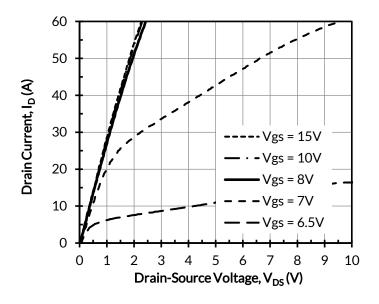


Figure 1. Typical output characteristics at T\_J = - 55°C, tp < 250 $\mu$ s

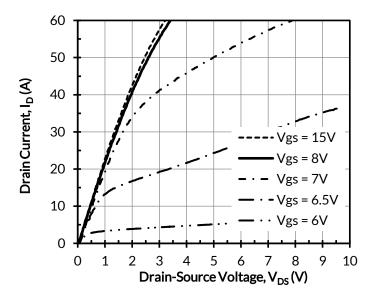


Figure 2. Typical output characteristics at T  $_{\rm J}$  = 25°C, tp < 250 $\mu s$ 

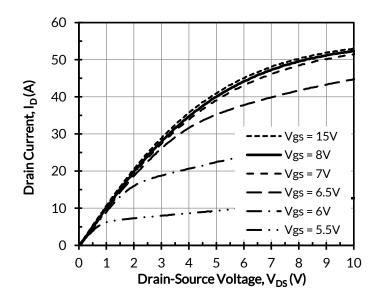


Figure 3. Typical output characteristics at T  $_{\rm J}$  = 175°C, tp < 250 $\mu s$ 

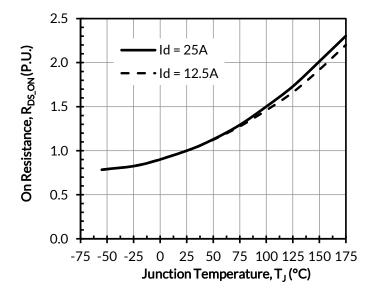


Figure 4. Normalized on-resistance vs. temperature at  $V_{\text{GS}}$  = 12V





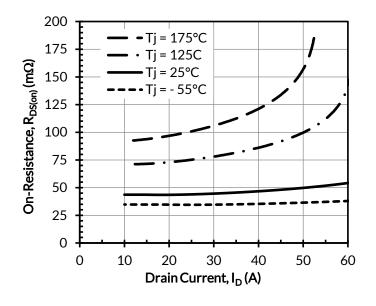


Figure 5. Typical drain-source on-resistances at  $V_{\text{GS}}$  = 12V

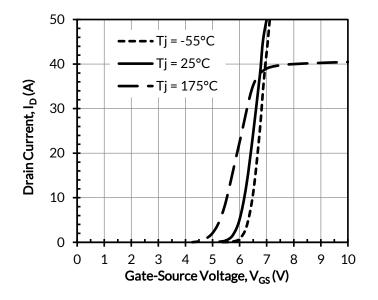


Figure 6. Typical transfer characteristics at  $V_{DS}$  = 5V

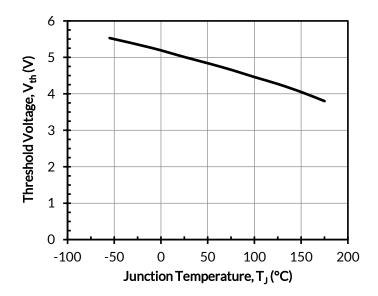


Figure 7. Threshold voltage vs. junction temperature at  $V_{\text{DS}}$  = 5V and  $I_{\text{D}}$  = 10mA

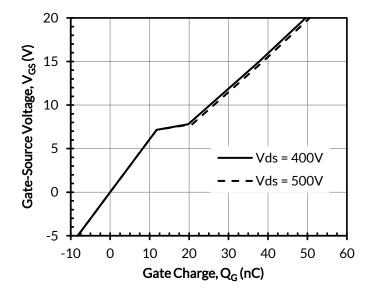


Figure 8. Typical gate charge at  $I_D$  = 25A



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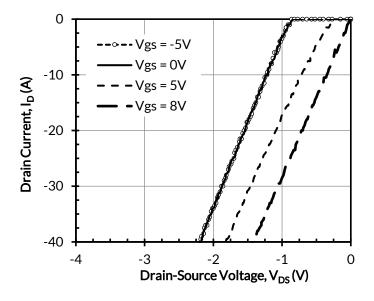


Figure 9. 3rd quadrant characteristics at  $T_J = -55^{\circ}C$ 

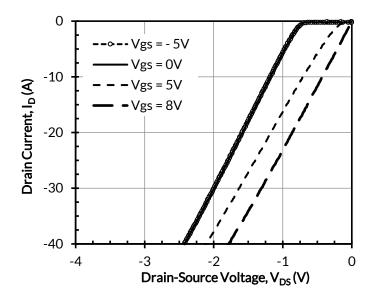


Figure 10. 3rd quadrant characteristics at  $T_J = 25^{\circ}C$ 

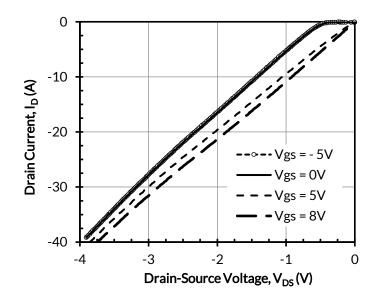


Figure 11. 3rd quadrant characteristics at T<sub>J</sub> = 175°C

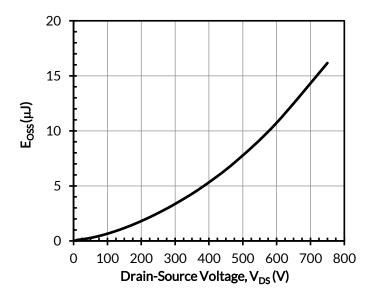


Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS}$  = 0V



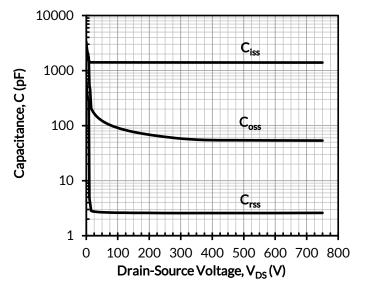
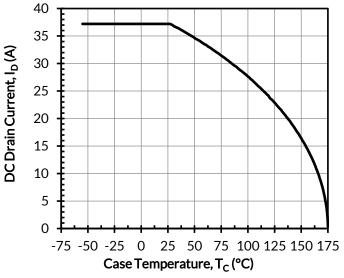


Figure 13. Typical capacitances at f = 100kHz and  $V_{GS}$  = 0V



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Figure 14. DC drain current derating

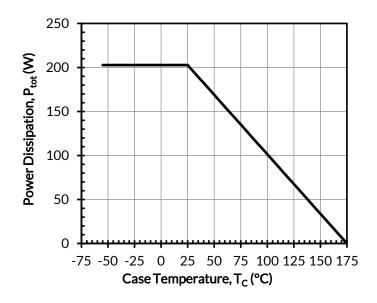


Figure 15. Total power dissipation

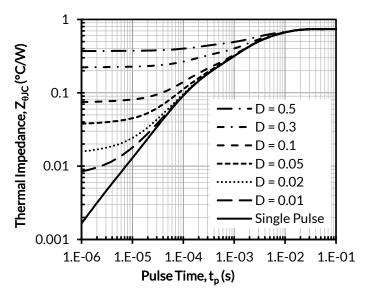


Figure 16. Maximum transient thermal impedance



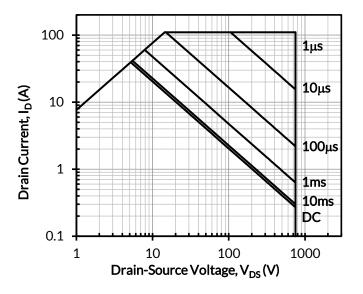


Figure 17. Safe operation area at  $T_{C}$  = 25°C, D = 0, Parameter  $t_{\rm p}$ 

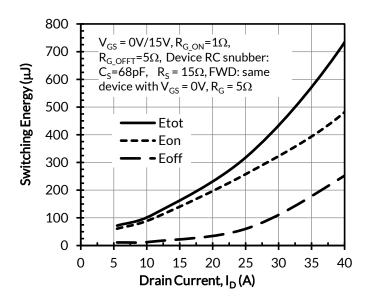
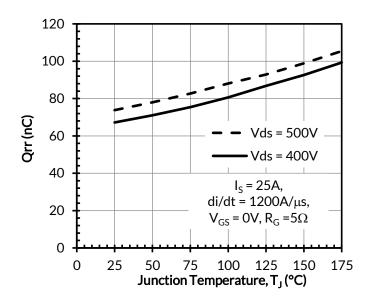


Figure 19. Clamped inductive switching energy vs. drain current at  $V_{DS}$  = 400V and  $T_J$  = 25°C



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Figure 18. Reverse recovery charge Qrr vs. junction temperature

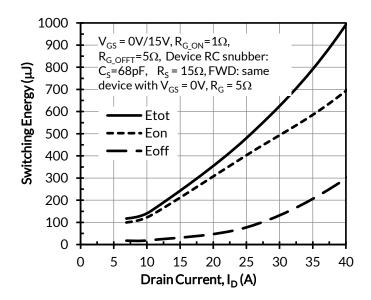


Figure 20. Clamped inductive switching energy vs. drain current at  $V_{DS}$  = 500V and  $T_J$  = 25°C





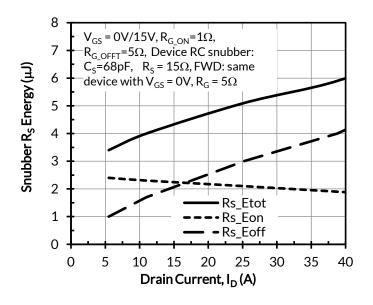


Figure 21. RC snubber energy loss vs. drain current at  $V_{DS}$  = 400V and  $T_J$  = 25°C

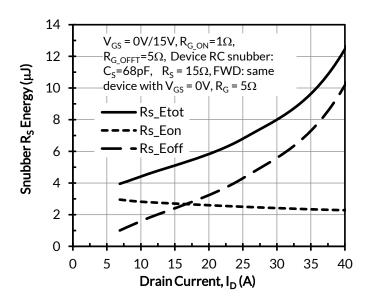


Figure 22. RC snubber energy losses vs. drain current at  $V_{DS}$  = 500V and  $T_J$  = 25°C

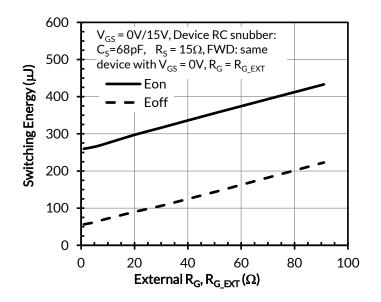


Figure 23. Clamped inductive switching energies vs.  $R_{G,EXT}$  at  $V_{DS}$  = 400V,  $I_D$  = 25A, and  $T_J$  = 25°C

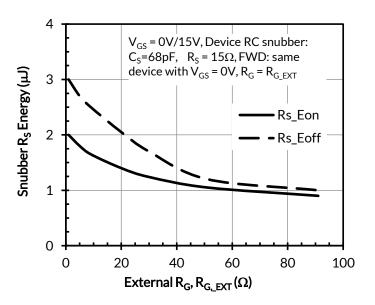
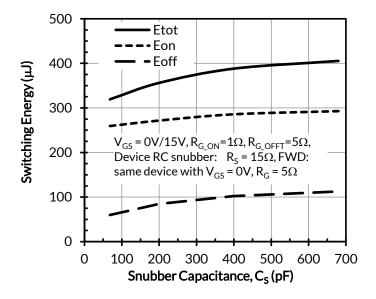
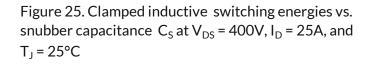


Figure 24. RC snubber energy losses vs.  $R_{G,EXT}$  at  $V_{DS}$  = 400V,  $I_D$  = 25A, and  $T_1$  = 25°C









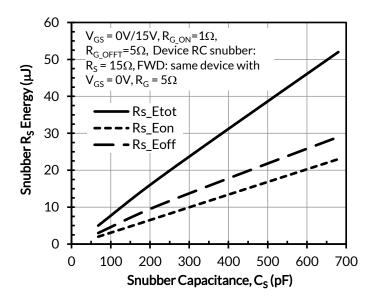


Figure 26. RC snubber energy losses vs. snubber capacitance  $C_S$  at  $V_{DS}$  = 400V,  $I_D$  =25A, and  $T_J$  = 25°C

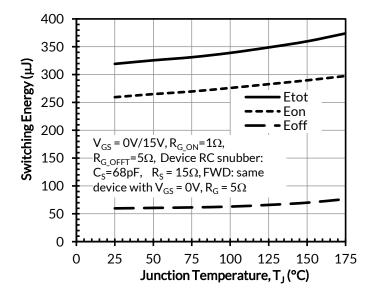


Figure 27. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  =400V and  $I_D$  = 25A

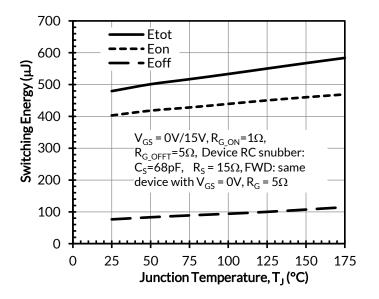


Figure 28. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  =500V and  $I_D$  =25A





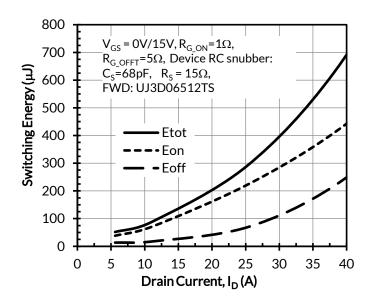


Figure 29. Clamped inductive switching energy vs. drain current at  $V_{DS}$  = 400V and  $T_J$  = 25°C

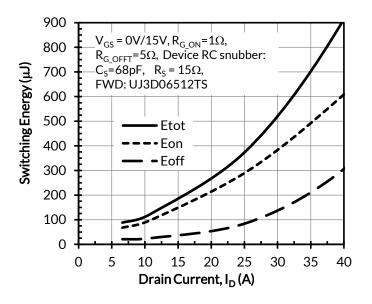


Figure 30. Clamped inductive switching energy vs. drain current at  $V_{DS}$  = 500V and  $T_J$  = 25°C

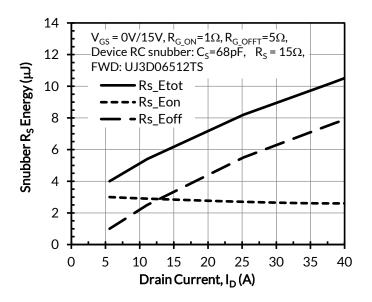


Figure 31. RC snubber energy losses vs. drain current at  $V_{\rm DS}$  = 400V and  $T_{\rm J}$  = 25°C

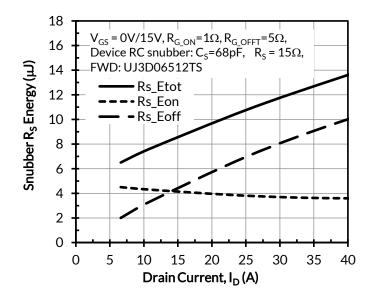


Figure 32. RC snubber energy losses vs. drain current at  $V_{DS}$  = 500V and  $T_J$  = 25°C



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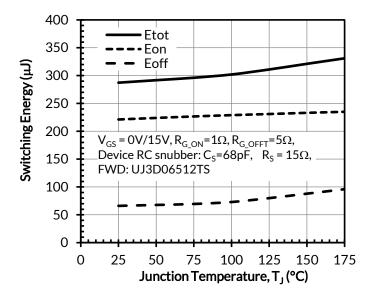


Figure 33. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  =400V and  $I_D$  = 25A

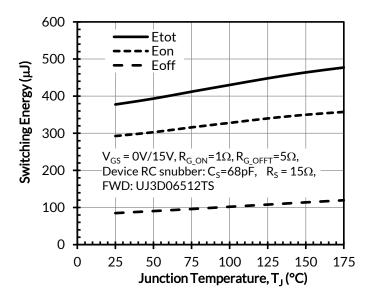


Figure 34. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  =500V and  $I_D$  =25A

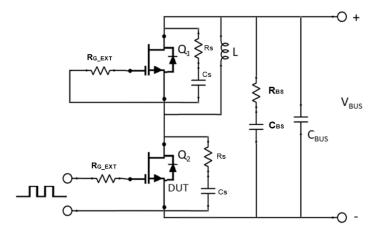


Figure 35. Schematic of the half-bridge mode switching test circuit. Note, a bus RC snubber ( $R_{BS} = 5\Omega$ ,  $C_{BS} = 100$ nF) is used to reduce the power loop high frequency oscillations.

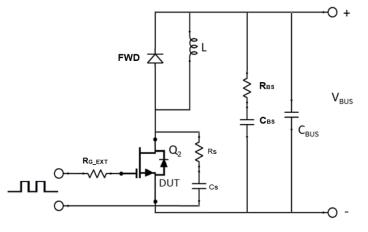


Figure 36. Schematic of the chopper mode switching test circuit. Note, a bus RC snubber ( $R_{BS} = 5\Omega$ ,  $C_{BS}=100$ nF) is used to reduce the power loop high frequency oscillations.





#### **Applications Information**

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{DS(on)}$ ), output capacitance ( $C_{oss}$ ), gate charge ( $Q_G$ ), and reverse recovery charge ( $Q_{rr}$ ) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

A snubber circuit with a small  $R_{(G)}$ , or gate resistor, provides better EMI suppression with higher efficiency compared to using a high  $R_{(G)}$  value. There is no extra gate delay time when using the snubber circuitry, and a small  $R_{(G)}$  will better control both the turn-off  $V_{(DS)}$  peak spike and ringing duration, while a high  $R_{(G)}$  will damp the peak spike but result in a longer delay time. In addition, the total switching loss when using a snubber circuit is less than using high  $R_{(G)}$ , while greatly reducing  $E_{(OFF)}$  from mid-to-full load range with only a small increase in  $E_{(ON)}$ . Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the UnitedSiC website at www.unitedsic.com

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